Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/806,490	KUBICZEK ET AL.	
Examiner	Art Unit	
Daniel Pan	2183	

	SEAR	CHED	
Class	Subclass	Date	Examiner
712	203 204 209 243	4/20/2005	DP
717	118	4/20/2005	DP
			48.0

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARC (INCLUDING SE	CH NOTES ARCH STRATEG	Y)
	DATE	EXMR
West searched IEEE npl searched	4/20/2005	